



### **Dual N-Channel 30 V (D-S) MOSFETs**

PRODU	CT SU	MMARY		
	V <sub>DS</sub> (V)	$R_{DS(on)}\left(\Omega\right)$ (Max.)	<b>I<sub>D</sub> (A)</b> <sup>g</sup>	Q <sub>g</sub> (Typ.)
Channel-1	30	0.00640 at V <sub>GS</sub> = 10 V	16 <sup>a</sup>	7.2 nC
Chamilei-1	30	$0.01000 \text{ at V}_{GS} = 4.5 \text{ V}$	16 <sup>a</sup>	7.2110
Channel-2 30		$0.00137$ at $V_{GS} = 10 \text{ V}$	40 <sup>a</sup>	30.1 nC
Chamilei-2	30	$0.00194$ at $V_{GS} = 4.5 \text{ V}$	40 <sup>a</sup>	30.1110

# PowerPAIR® 6 x 5 5 mm 6 mm

**Ordering Information:** SiZ914DT-T1-GE3 (Lead (Pb)-free and Halogen-free)

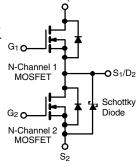
#### **FEATURES**

- TrenchFET® Gen IV Power MOSFETs
- 100 % R<sub>a</sub> and UIS Tested
- Material categorization: For definitions of compliance please see www.vishay.com/doc?99912



#### **APPLICATIONS**

- **CPU Core Power**
- Computer/Server Peripherals
- Synchronous Buck Converter
- POL
- Telecom DC/DC



Parameter	Symbol	Channel-1	Channel-2	Unit	
Drain-Source Voltage	V <sub>DS</sub>	(			
Gate-Source Voltage	$V_{GS}$	+ 20	V		
	T <sub>C</sub> = 25 °C		16 <sup>a</sup>	40 <sup>a</sup>	
Continuous Dunin Comment /T 150 °C)	T <sub>C</sub> = 70 °C	1 ,	16 <sup>a</sup>	40 <sup>a</sup>	
Continuous Drain Current (T <sub>J</sub> = 150 °C)	T <sub>A</sub> = 25 °C	l <sub>D</sub>	16 <sup>a, b, c</sup>	40 <sup>a, b, c</sup>	1
	T <sub>A</sub> = 70 °C		15.5 <sup>b, c</sup>	38.8 <sup>b, c</sup>	1
Pulsed Drain Current (t = 100 μs)		I <sub>DM</sub>	80	100	Α
0 11 0 0 1	T <sub>C</sub> = 25 °C	1	19	28	
Continuous Source Drain Diode Current	T <sub>A</sub> = 25 °C	- I <sub>S</sub>	3.25 <sup>b, c</sup>	4.3 <sup>b, c</sup>	
Single Pulse Avalanche Current	L = 0.1 mH	I <sub>AS</sub>	10	20	
Single Pulse Avalanche Energy	L = 0.1 IIII1	E <sub>AS</sub>	5	20	mJ
	$T_C = 25 ^{\circ}C$	P <sub>D</sub>	22.7	100	
Maximum Power Discipation	$T_C = 70  ^{\circ}C$		14.5	64	w
Maximum Power Dissipation	T <sub>A</sub> = 25 °C		3.9 <sup>b, c</sup>	5.2 <sup>b, c</sup>	T VV
	T <sub>A</sub> = 70 °C		2.5 <sup>b, c</sup>	3.3 <sup>b, c</sup>	
Operating Junction and Storage Temperature Range		T <sub>J</sub> , T <sub>stg</sub>	- 55 to 150		
Soldering Recommendations (Peak Temperature		2	°C		

THERMAL RESISTANCE RATIN	GS						
			Char	nnel-1	Char	nel-2	
Parameter		Symbol	Тур.	Max.	Тур.	Max.	Unit
Maximum Junction-to-Ambient <sup>b, f</sup>	t ≤ 10 s	R <sub>thJA</sub>	25	32	19	24	°C/W
Maximum Junction-to-Case (Drain)	Steady State	R <sub>thJC</sub>	4.4	5.5	1	1.25	C/VV

#### Notes:

- a. Package limited
- b. Surface mounted on 1" x 1" FR4 board.
- d. See solder profile (www.vishay.com/doc?73257). The PowerPAIR is a leadless package. The end of the lead terminal is exposed copper (not plated) as a result of the singulation process in manufacturing. A solder fillet at the exposed copper tip cannot be guaranteed and is not required to ensure adequate bottom side solder interconnection.
- e. Rework conditions: manual soldering with a soldering iron is not recommended for leadless components.
- f. Maximum under steady state conditions is 62 °C/W for channel-1 and 55 °C/W for channel-2.
- g.  $T_C = 25$  °C.

### SiZ914DT

## Vishay Siliconix



SPECIFICATIONS (T $_J$ = 25 $^\circ$	C, unless ot	herwise noted)						
Parameter	Symbol	Test Conditions		Min.	Тур.	Max.	Unit	
Static								
Drain-Source Breakdown Voltage	V <sub>DS</sub>	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$ Ch-1 30		30			V	
Diain-Source Breakdown Voltage	VDS	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$	Ch-2	30			V V nA μA A O S pF	
Gate Threshold Voltage	V <sub>GS(th)</sub>	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$	Ch-1	1.2		2.4	V	
date Theshold Voltage	VGS(th)	$V_{DS} = V_{GS}$ , $I_D = 250 \mu A$	Ch-2	1		2.4	V	
Gate Source Leakage	I <sub>GSS</sub>	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 20 \text{ V}, -16 \text{ V}$	Ch-1			± 100	nA	
adio Codi do Edanago	-033		Ch-2			± 100		
		V <sub>DS</sub> = 30 V, V <sub>GS</sub> = 0 V	Ch-1			1		
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>DS</sub> = 30 V, V <sub>GS</sub> = 0 V	Ch-2		60	240	μΑ	
	200	$V_{DS} = 30 \text{ V}, V_{GS} = 0 \text{ V}, T_{J} = 55 ^{\circ}\text{C}$	Ch-1			5		
		$V_{DS} = 30 \text{ V}, V_{GS} = 0 \text{ V}, T_{J} = 55 ^{\circ}\text{C}$	Ch-2		0.5	5	V V nA μA A O S pF	
On-State Drain Current <sup>b</sup>	I <sub>D(on)</sub>	$V_{DS} \ge 5 \text{ V}, V_{GS} = 10 \text{ V}$	Ch-1	20			А	
On State Brain Surrent	D(OII)	$V_{DS} \ge 5 \text{ V}, V_{GS} = 10 \text{ V}$	Ch-2	25				
		$V_{GS} = 10 \text{ V}, I_D = 19 \text{ A}$	Ch-1		0.00530	0.00640		
Drain-Source On-State Resistance <sup>b</sup>	Book	V <sub>GS</sub> = 10 V, I <sub>D</sub> = 20 A	Ch-2		0.00114	0.00137	0	
	R <sub>DS(on)</sub>	$V_{GS} = 4.5 \text{ V}, I_D = 15 \text{ A}$	Ch-1		0.00800	0.01000	2.2	
		$V_{GS} = 4.5 \text{ V}, I_D = 20 \text{ A}$	Ch-2		0.00155	0.00194		
h	a.	V <sub>DS</sub> = 10 V, I <sub>D</sub> = 19 A	Ch-1		55		-	
Forward Transconductance <sup>b</sup>	9 <sub>fs</sub>	V <sub>DS</sub> = 10 V, I <sub>D</sub> = 20 A	Ch-2		68		5	
Dynamic <sup>a</sup>								
Input Capacitance	C <sub>iss</sub>		Ch-1		1208			
mpat Supusitanos	Olss	Channal 1	Ch-2		5603			
Output Capacitance	C <sub>oss</sub>	Channel-1 $V_{DS} = 15 \text{ V}, V_{GS} = 0 \text{ V}, f = 1 \text{ MHz}$	Ch-1		375		pF	
	- 055	VDS = 10 1, 1GS = 0 1, 1 = 1 1011 12	Ch-2		2202			
Reverse Transfer Capacitance	C <sub>rss</sub>	Channel-2	Ch-1		30			
<u> </u>	100	$V_{DS} = 15 \text{ V}, V_{GS} = 0 \text{ V}, f = 1 \text{ MHz}$	Ch-2		168		V nA μA πA A Ω Ω Ω η Γ Ω Ω η Γ Ω Ω η Γ Ω Ω η Γ Ω Ω η Γ Ω Ω η Γ Ω Ω η Γ Ω Ω η Γ Ω Ω η Γ Ω Ω Ω Ω	
C <sub>rss</sub> /C <sub>iss</sub> Ratio			Ch-1		0.025		00 nA 00 nA 00 μA 60 μA 63 mA 640 137 000 194 S pF 50 64 66 9 1 .2	
	_	V 45 V V 40 V L 00 A	Ch-2		0.032			
		$V_{DS} = 15 \text{ V}, V_{GS} = 10 \text{ V}, I_{D} = 20 \text{ A}$	Ch-1		17			
Total Gate Charge	$Q_g$	$V_{DS} = 15 \text{ V}, V_{GS} = 10 \text{ V}, I_{D} = 20 \text{ A}$	Ch-2		66		μA mA A Ω S	
	J	Channel-1	Ch-1		7.2			
		$V_{DS} = 15 \text{ V}, V_{GS} = 4.5 \text{ V}, I_D = 20 \text{ A}$	Ch-2		30.1	45.2		
Gate-Source Charge	$Q_{gs}$	20 7 40 7 5	Ch-1 Ch-2		3.6			
	3.	Channel-2			10.9			
Gate-Drain Charge	$Q_{gd}$	$V_{DS} = 15 \text{ V}, V_{GS} = 4.5 \text{ V}, I_D = 20 \text{ A}$	Ch-1 Ch-2		0.94 3.8		1	
			Ch-1		10			
Output Charge	Q <sub>oss</sub>	$V_{DS} = 15 \text{ V}, V_{GS} = 0 \text{ V}$	Ch-2		60			
			Ch-1	0.5	2.5	5	0.00640 0.00137 0.001000 0.00194 S pF 0.050 0.064 26 99 11 45.2 nC	
Gate Resistance	$R_g$	f = 1 MHz	Ch-2	0.2	1		Ω	

a. Guaranteed by design, not subject to production testing.

b. Pulse test; pulse width  $\leq$  300  $\mu$ s, duty cycle  $\leq$  2 %.





Parameter	Symbol Test Conditions			Min.	Тур.	Max.	Unit
Dynamic <sup>a</sup>					•		
Turn-On Delay Time	t <sub>d(on)</sub>	Channel-1	Ch-1		16	24	
,	=()	$V_{DD} = 15 \text{ V}, R_1 = 1.5 \Omega$	Ch-2		40	60	
Rise Time	t <sub>r</sub>	$I_D \cong 10 \text{ A}, V_{GEN} = 4.5 \text{ V}, R_g = 1 \Omega$	Ch-1 Ch-2		11 127	20 190	
	_	Ohannal O	Ch-1		15	23	
Turn-Off Delay Time	t <sub>d(off)</sub>	Channel-2 $V_{DD} = 15 \text{ V}, R_{L} = 1.5 \Omega$	Ch-2		40	60	
Fall Time	t <sub>f</sub>	$I_D \cong 10 \text{ A}, V_{GEN} = 4.5 \text{ V}, R_q = 1 \Omega$	Ch-1		5	10	-
raii Time	ч	g GEN g	Ch-2		19	29	
Turn On Dolov Timo	t., ,		Ch-1		10	20	ns
Turn-On Delay Time	t <sub>d(on)</sub>	Channel-1	Ch-2		12	20	
Rise Time	t <sub>r</sub>	$V_{DD} = 15 \text{ V}, R_L = 1.5 \Omega$	Ch-1		10	20	
Tuse Time	۲	$I_D \cong 10 \text{ A}, V_{GEN} = 10 \text{ V}, R_g = 1 \Omega$	Ch-2		30	45	
Turn-Off Delay Time	t <sub>d(off)</sub>	Channel-2 $V_{DD} = 15 \text{ V, R}_{L} = 1.5 \Omega$			20	30	
Turn-On Belay Time	·a(on)				35	53	
Fall Time $t_f = I_D \cong 10 \text{ A, V}_G$		$I_D \cong 10 \text{ A}, V_{GEN} = 10 \text{ V}, R_g = 1 \Omega$	Ch-1		5	10	
			Ch-2		7	14	
<b>Drain-Source Body Diode Characteristic</b>	s	,					
Continuous Source-Drain Diode Current	I <sub>S</sub>	T <sub>C</sub> = 25 °C	Ch-1			40	
		-	Ch-2			40	Α
Pulse Diode Forward Current (t = 100 μs)	I <sub>SM</sub>		Ch-1			80	
		I <sub>S</sub> = 10 A, V <sub>GS</sub> = 0 V	Ch-2 Ch-1		0.8	100	
Body Diode Voltage	$V_{SD}$	$I_S = 2 \text{ A}, V_{GS} = 0 \text{ V}$	Ch-2		0.33	0.42	V
		15 - 271, VGS - 0 V	Ch-1		15	23	
Body Diode Reverse Recovery Time	t <sub>rr</sub>		Ch-2		62	93	ns
	Q <sub>rr</sub>	Channel-1	Ch-1		4	8	
Body Diode Reverse Recovery Charge		$I_F = 10 \text{ A}, \text{ dI/dt} = 100 \text{ A/}\mu\text{s}, T_J = 25 ^{\circ}\text{C}$	Ch-2		96	144	nC
Daviera Danavier Fall Time		Channel-2	Ch-1		9		
Reverse Recovery Fall Time	t <sub>a</sub>	$I_F = 10 \text{ A}, \text{ dI/dt} = 100 \text{ A/}\mu\text{s}, T_J = 25 °C$	Ch-2		30.5		
Payaraa Pagayary Pina Tima	t.	, , , , , , , , , , , , , , , , , , , ,	Ch-1		6		ns
Reverse Recovery Rise Time	t <sub>b</sub>		Ch-2		31.5		

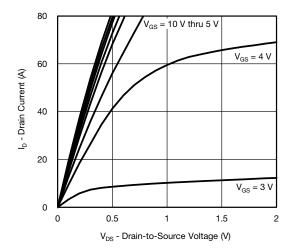
#### Notes:

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

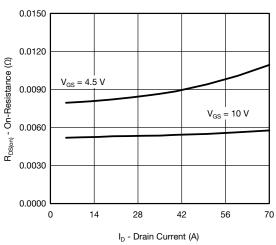
a. Guaranteed by design, not subject to production testing.

b. Pulse test; pulse width  $\leq$  300  $\mu$ s, duty cycle  $\leq$  2 %.

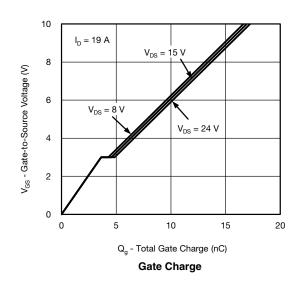
### CHANNEL-1 TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

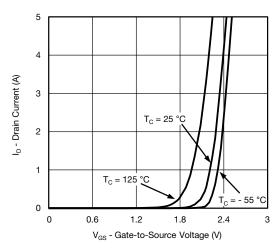


#### **Output Characteristics**

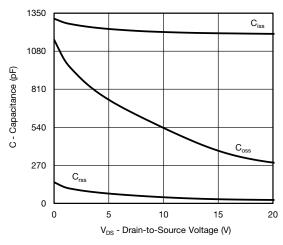


#### On-Resistance vs. Drain Current

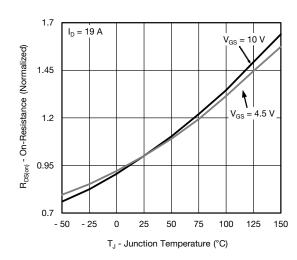




#### **Transfer Characteristics**



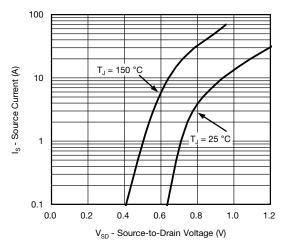
#### Capacitance



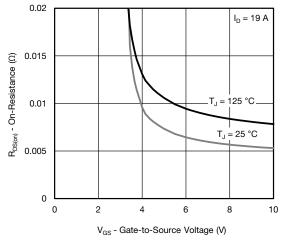
On-Resistance vs. Junction Temperature



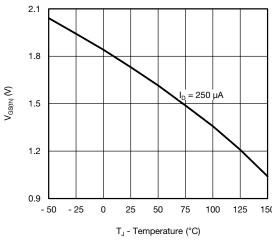
### CHANNEL-1 TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



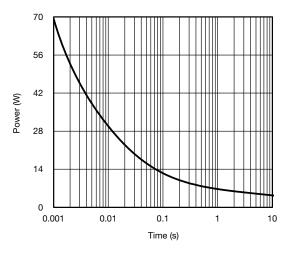
#### Source-Drain Diode Forward Voltage



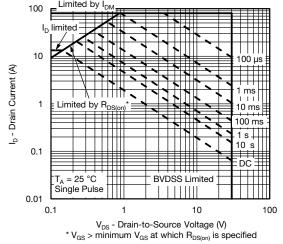
On-Resistance vs. Gate-to-Source Voltage



Threshold Voltage

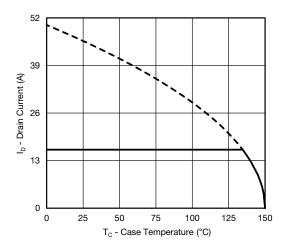


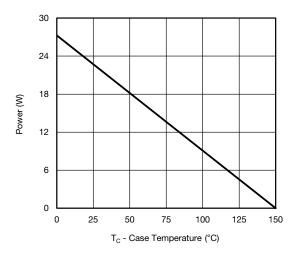
Single Pulse Power, Junction-to-Ambient



Safe Operating Area, Junction-to-Ambient

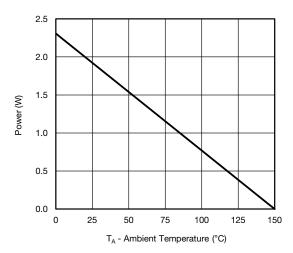
### CHANNEL-1 TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)





**Current Derating\*** 

Power, Junction-to-Case

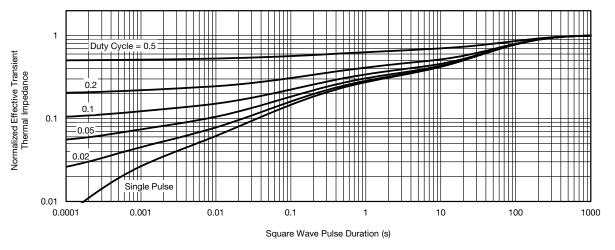


Power, Junction-to-Ambient

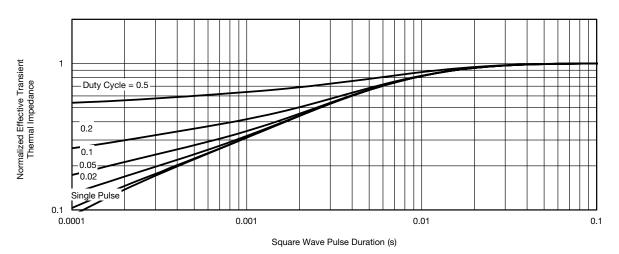
<sup>\*</sup> The power dissipation  $P_D$  is based on  $T_{J(max.)}$  = 150 °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.



### CHANNEL-1 TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

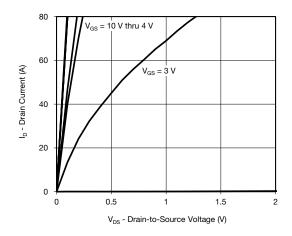


#### Normalized Thermal Transient Impedance, Junction-to-Ambient

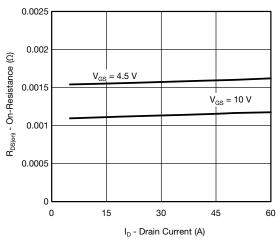


Normalized Thermal Transient Impedance, Junction-to-Case

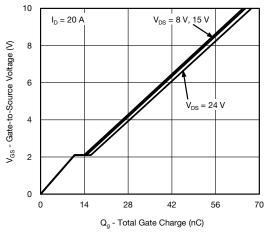
### CHANNEL-2 TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



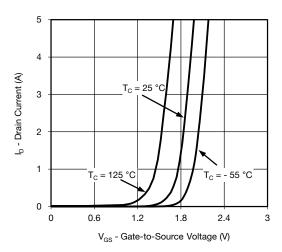
#### **Output Characteristics**



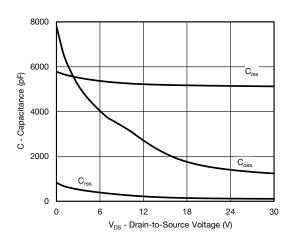
#### On-Resistance vs. Drain Current



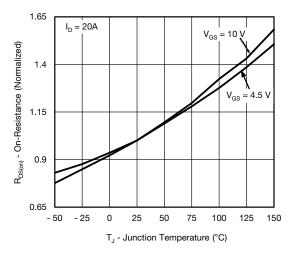
**Gate Charge** 



**Transfer Characteristics** 



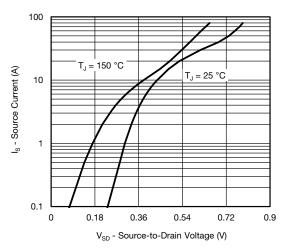
#### Capacitance



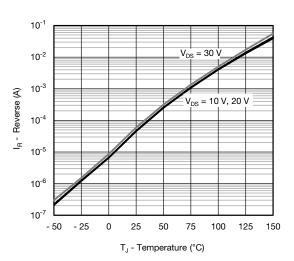
On-Resistance vs. Junction Temperature



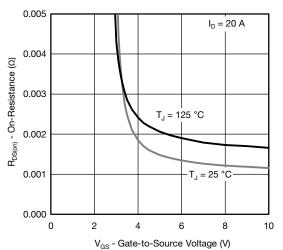
#### CHANNEL-2 TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



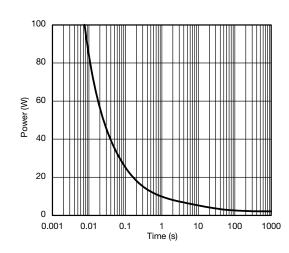
#### Source-Drain Diode Forward Voltage



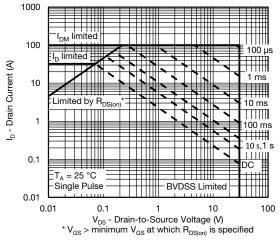
Reverse Current (Schottky)



On-Resistance vs. Gate-to-Source Voltage



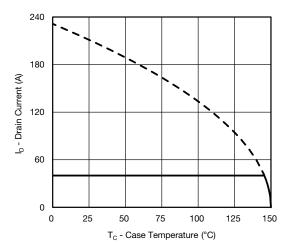
Single Pulse Power, Junction-to-Ambient

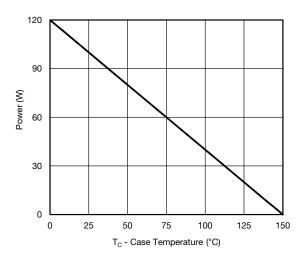


Safe Operating Area, Junction-to-Ambient



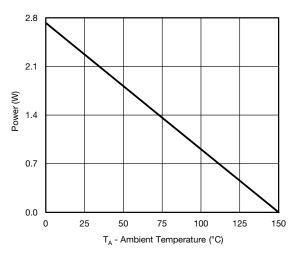
### CHANNEL-2 TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)





**Current Derating\*** 

Power, Junction-to-Case

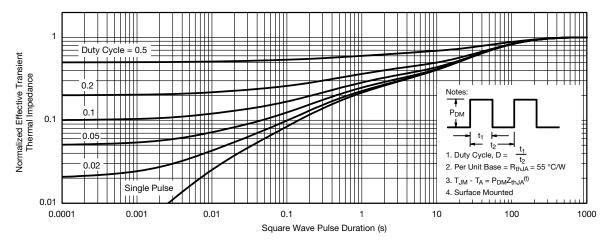


Power, Junction-to-Ambient

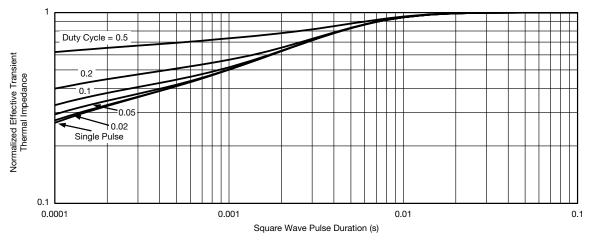
<sup>\*</sup> The power dissipation  $P_D$  is based on  $T_{J(max.)}$  = 150 °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.



#### CHANNEL-2 TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



#### Normalized Thermal Transient Impedance, Junction-to-Ambient

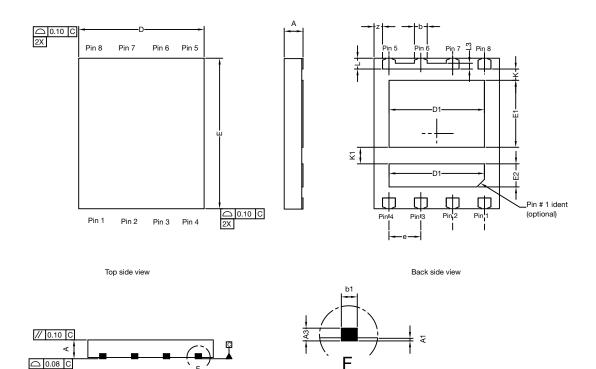


Normalized Thermal Transient Impedance, Junction-to-Case

Vishay Siliconix maintains worldwide manufacturing capability. Products may be manufactured at one of several qualified locations. Reliability data for Silicon Technology and Package Reliability represent a composite of all qualified locations. For related documents such as package/tape drawings, part marking, and reliability data, see www.vishay.com/ppg?62905.



## PowerPAIR® 6 x 5 Case Outline

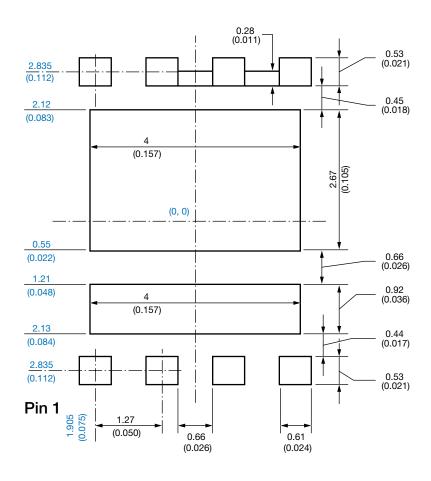


		MILLIMETERS		INCHES				
DIM.	MIN.	NOM.	MAX.	MIN.	NOM.	MAX.		
А	0.70	0.75	0.80	0.028	0.030	0.032		
A1	0.00	-	0.10	0.000	-	0.004		
A3	0.15	0.20	0.25	0.006	0.007	0.009		
b	0.43	0.51	0.61	0.017	0.020	0.024		
b1		0.25 BSC			0.010 BSC			
D	4.90	5.00	5.10	0.192	0.196	0.200		
D1	3.75	3.80	3.85	0.148	0.150	0.152		
E	5.90	6.00	6.10	0.232	0.236	0.240		
E1 Option AA (for W/B)	2.62	2.67	2.72	0.103	0.105	0.107		
E1 Option AB (for BWL)	2.42	2.47	2.52	0.095	0.097	0.099		
E2	0.87	0.92	0.97	0.034	0.036	0.038		
е		1.27 BSC 0.050 BSC						
K Option AA (for W/B)		0.45 typ.		0.018 typ.				
K Option AB (for BWL)		0.65 typ.			0.025 typ.			
K1	0.66 typ.			0.025 typ.				
L	0.33	0.43	0.53	0.013	0.017	0.020		
L3	0.23 BSC 0.009 BSC							
Z	0.34 BSC			0.013 BSC				

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## Recommended Minimum PAD for PowerPAIR® 6 x 5



Dimensions in millimeters (inch)

#### Note

• Linear dimensions are in black, the same information is provided in ordinate dimensions which are in blue.



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